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App	licati	on/C	ontro	No.	

09/925,247 Examiner

Jia W. Lu

Applicant(s)/Patent under Reexamination

AWAD ET AL. Art Unit

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	SEAR	CHED	
Class	Subclass	Date	Examiner
375	232	4/20/2005	JL
375	290	4/20/2005	JL
375	229	4/20/2005	JL
708	322	4/20/2005	JL
375	371	4/20/2005	JL
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
375	232	4/20/2005	JL		
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	4/20/2005	JL
INVENTORSHIP	4/20/2005	JL
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